1.5V Drive Nch+SBD MOSFET

QS5U36

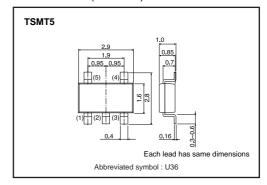
●Structure

Silicon N-channel MOSFET Schottky Barrier DIODE

● Features

- 1) The QS5U36 combines Nch MOSFET with a Schottky barrier diode in a single TSMT5 package.
- 2) Low on-state resistance with fast switching.
- 3) Low voltage drive (1.5V).
- 4) The Independently connected Schottky barrier diode has low forward voltage.

●Dimensions (Unit:mm)



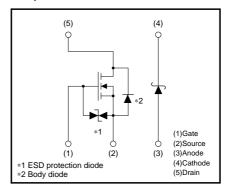
Applications

Switching

Packaging specifications

	Package	Taping
Туре	Code	TR
	Basic ordering unit (pieces)	3000
QS5U36		0

Equivalent circuit



● Absolute maximum ratings (Ta=25°C)

<MOSFET>

Parameter	Symbol	Limits	Unit			
Drain-source voltage	V _{DSS}	20	V			
Gate-source voltage		V _{GSS}	±10	V		
Drain current	Continuous	lο	±2.5	Α		
Diam current	Pulsed	I _{DP} *1	±5.0	А		
Source current	Continuous	Is	0.7	А		
(Body diode)	Pulsed	I _{SP} *1	5.0	Α		
Channel temperature		Tch	150	°C		
Power dissipation	P _D *3	0.9	W/ELEMENT			
<di></di>						
Repetitive peak reverse volt	V _{RM}	25	V			
Reverse voltage	V_R	20	V			
Forward current	l _F	0.7	Α			
Forward current surge peak	I _{FSM} *2	3.0	Α			
Junction temperature	Tj	150	°C			
Power dissipation	P _D *3	0.7	W/ELEMENT			
<mosfet and="" di=""></mosfet>						
Total power dissipation	P _D *3	1.25	W / TOTAL			
Range of storage temperatu	Tstg	-55 to +150	°C			

^{*1} Pw≤10μs, Duty cycle≤1% *2 60Hz•1cyc. *3 Mounted on a ceramic board

●Electrical characteristics (Ta=25°C)

<MOSFET>

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Gate-source leakage	I _{GSS}	-	-	±10	μΑ	V _{GS} =±10V / V _{DS} =0V
Drain-source breakdown voltage	V _{(BR) DSS}	20	_	_	V	I _D =1mA, / V _{GS} =0V
Zero gate voltage drain current	IDSS	_	-	1	μΑ	Vps=20V / Vgs=0V
Gate threshold voltage	V _{GS (th)}	0.3	-	1.3	V	V _{DS} =10V / I _D =1mA
		_	58	81	$m\Omega$	I _D =2.5A, V _{GS} =4.5V
Static drain-source on-state	D *	-	74	104	$m\Omega$	I _D =2.5A, V _{GS} =2.5V
resistance	R _{DS (on)} *	-	95	133	$m\Omega$	I _D =1.3A, V _{GS} =1.8V
		-	120	240	$m\Omega$	I _D =0.5A, V _{GS} =1.5V
Forward transfer admittance	Y _{fs} *	2.7	-	_	S	V _{DS} =10V, I _D =2.5A
Input capacitance	Ciss	-	280	_	рF	V _{DS} =10V
Output capacitance	Coss	-	65	_	pF	V _{GS} =0V
Reverse transfer capacitance	Crss	-	35	_	pF	f=1MHz
Turn-on delay time	t _{d (on)} *	-	6	_	ns	ID=1.3A
Rise time	tr *	-	15	_	ns	VDD≒10V VGS=4.5V
Turn-off delay time	t _{d (off)} *	-	30	_	ns	VGS=4.5V RL≒7.7Ω
Fall time	t _f *	-	15	_	ns	$R_{G}=10\Omega$
Total gate charge	Qg *	_	3.5	_	nC	I _D =2.5A, V _{DD} ≒10V
Gate-source charge	Q _{gs} *	-	0.8	_	nC	V _{GS} =4.5V
Gate-drain charge	Q _{gd} *	_	0.7	_	nC	RL≒4Ω, R _G =10Ω
*Pulsed						

<MOSFET>Body diode (source-drain)

(course						
Forward voltage	Vsp *	_	_	1.2	V	I _S =0.7A / V _{GS} =0V
*Pulsed						

<	ח	i>

Forward voltage	VF	-	-	0.49	V	I=0.7A
Reverse current	IR	_	_	200	μA	V _R =20V



•Electrical characteristic curves

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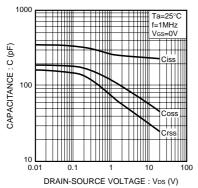


Fig.1 Typical Capacitance vs. Drain-Source Voltage

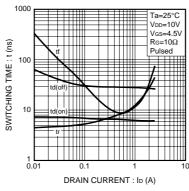


Fig.2 Switching Characteristics

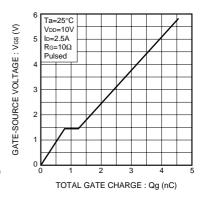


Fig.3 Dynamic Input Characteristics

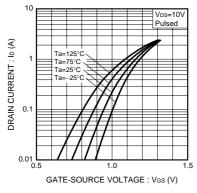


Fig.4 Typical Transfer Characteristics

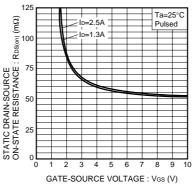


Fig.5 Static Drain-Source On-State Resistance vs. Gate-source Voltage

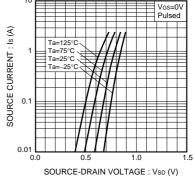


Fig.6 Source Current vs. Source-Drain Voltage

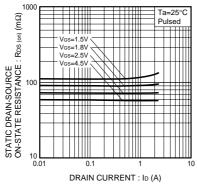


Fig.7 Static Drain-Source On-State Resistance vs. Drain Current (I)

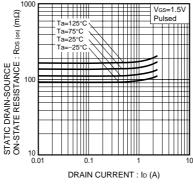


Fig.8 Static Drain-Source On-State Resistance vs. Drain Current (II)

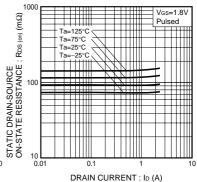
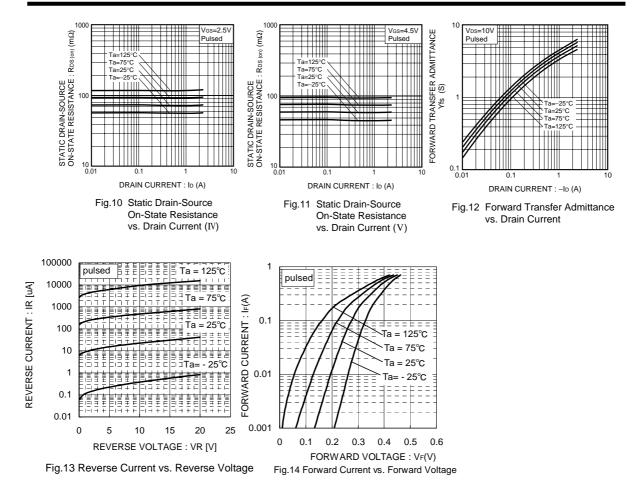


Fig.9 Static Drain-Source On-State Resistance vs. Drain Current (III)



Notice

- SBD has a large reverse leak current compared to other type of diode. Therefore; it would raise a junction temperature, and increase a reverse power loss. Further rise of inside temperature would cause a thermal runaway.
 This built-in SBD has low V_F characteristics and therefore, higher leak current. Please consider enough the surrounding temperature, generating heat of MOSFET and the reverse current.
- 2. This product might cause chip aging and breakdown under the large electrified environment. Please consider to design ESD protection circuit.

●Measurement circuit

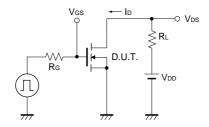


Fig.15 Switching Time Measurement Circuit

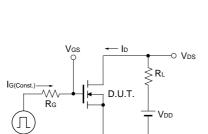


Fig.17 Gate Charge Measurement Circuit

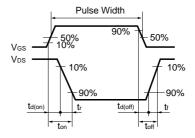


Fig.16 Switching Waveforms

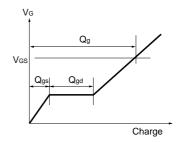


Fig.18 Gate Charge Waveform

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